

DF3A6.8FV

Diodes for Protecting against ESD

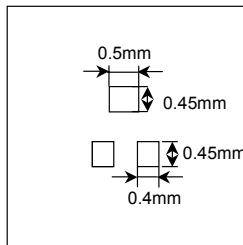
Unit: mm

- Incorporating two devices in a single ultra-compact package reduces the number of parts and lowers the mounting cost.
- The zener voltage corresponds to the E24 Series.

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Power dissipation	P*	150	mW
Junction temperature	T _j	150	°C
Storage temperature range	T _{stg}	-55~150	°C

* : Mounted on FR4 board (25.4 mm × 25.4 mm × 1.6 mm)



VESM	1.CATHODE1 2.CATHODE2 3.ANODE
JEDEC	—
JEITA	—
TOSHIBA	1-1Q1B

Weight: 0.0015g (typ.)

Electrical Characteristics (Ta = 25°C)

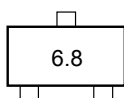
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Zener voltage	V _Z	I _Z = 5 mA	6.4	6.8	7.2	V
Dynamic impedance	Z _Z	I _Z = 5 mA	—	—	25	Ω
Reverse current	I _R	V _R = 5 V	—	—	0.5	μA
Terminal capacitance (between Cathode and Anode)	C _T	V _R = 0, f = 1MHz	—	45	—	pF

Guaranteed Level of ESD Immunity

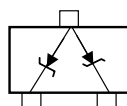
Test Condition	ESD Immunity Level
IEC61000-4-2 (Contact discharge)	± 30kV

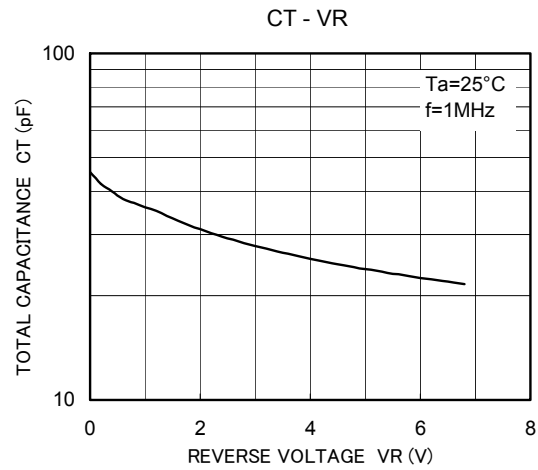
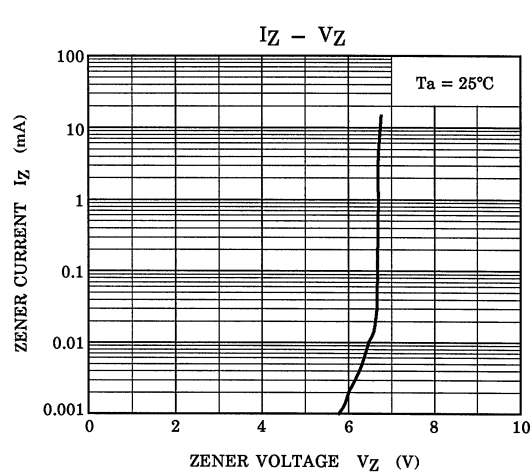
Criterion: No damage to device elements

Marking



Equivalent Circuit (top view)





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